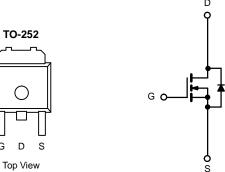


NTD4959NT4G-VB Datasheet N-Channel 30-V (D-S) MOSFET

| PRODUCT SUMMARY | | | | | | |
|---------------------|-------------------------------------|------------------------------------|----------------------|--|--|--|
| V _{DS} (V) | $R_{DS(on)}(\Omega)$ | I _D (A) ^{a, e} | Q _g (Typ) | | | |
| 30 | 0.005 at V _{GS} = 10 V | 80 | 31 nC | | | |
| 30 | 0.006 at $V_{GS} = 4.5 \text{ V}$ | 68 | 31110 | | | |

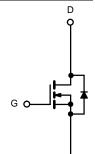


Compliant to RoHS Directive 2011/65/EU

Trench Power MOSFET 100 % R_q and UIS Tested

FEATURES

- **APPLICATIONS**
- OR-ing Server
- DC/DC



N-Channel MOSFET

| Parameter | | Symbol | Limit | Unit | |
|---|-----------------------------------|-----------------|----------------------|------|--|
| Drain-Source Voltage | V _{DS} | 30 | | | |
| Gate-Source Voltage | | V _{GS} | | ± 20 | |
| | T _C = 25 °C | | 80 | A | |
| Continuous Drain Current (T _{.I} = 175 °C) | T _C = 70 °C | L | 60 | | |
| Continuous Diain Current (1) = 173 C) | T _A = 25 °C | I _D | 25.8 ^{b, c} | | |
| | T _A = 70 °C | | 22 ^{b, c} | | |
| Pulsed Drain Current | I _{DM} | 250 | | | |
| Avalanche Current Pulse | L = 0.1 mH | I _{AS} | 39 | | |
| Single Pulse Avalanche Energy | L = 0.1 IIII | E _{AS} | 94.8 | mJ | |
| Continuous Source-Drain Diode Current | T _C = 25 °C | L | 90 ^{a, e} | А | |
| Continuous Source-Drain Diode Current | T _A = 25 °C | I _S | 3.13 ^{b, c} | A | |
| | T _C = 25 °C | | 205 ^a | w | |
| Maximum Daylar Dissipation | T _C = 70 °C | P _D | 135 | | |
| Maximum Power Dissipation | T _A = 25 °C | ' D | 3.75 ^{b, c} | | |
| | T _A = 70 °C | | 2.63 ^{b, c} | | |
| Operating Junction and Storage Temperature Ra | T _J , T _{stg} | - 55 to 175 | °C | | |

| THERMAL RESISTANCE RATINGS | | | | | | |
|---|--------------|-------------------|------|------|--------|--|
| Parameter | | Symbol | Тур. | Max. | Unit | |
| Maximum Junction-to-Ambient ^{b, d} | t ≤ 10 sec | R _{thJA} | 32 | 40 | °C/W | |
| Maximum Junction-to-Case | Steady State | R _{thJC} | 0.5 | 0.6 | - C/VV | |

Notes:

- a. Based on T_C = 25 °C.
 b. Surface mounted on 1" x 1" FR4 board.

- b. Striate informed on 1 X 1 114 board.
 c. t = 10 sec.
 d. Maximum under steady state conditions is 90 °C/W.
 e. Calculated based on maximum junction temperature. Package limitation current is 90 A.



| Parameter | Symbol | Test Conditions | Min. | Тур. | Max. | Unit |
|---|-------------------------|--|------|-------|-------|-------|
| Static | | | | | | • |
| Drain-Source Breakdown Voltage | V _{DS} | $V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$ | | | | V |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | I _D = 250 μA | | 35 | | mV/°C |
| V _{GS(th)} Temperature Coefficient | $\Delta V_{GS(th)}/T_J$ | I _D = 250 μA | | - 7.5 | | |
| Gate-Source Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}, I_D = 250 \mu A$ | 1.0 | | 2.5 | V |
| Gate-Source Leakage | I _{GSS} | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$ | | | ± 100 | nA |
| | | $V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$ | | | 1 | μΑ |
| Zero Gate Voltage Drain Current | I _{DSS} | $V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$ | | | 10 | |
| On-State Drain Current ^a | I _{D(on)} | $V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$ | 90 | | | Α |
| | D | V _{GS} = 10 V, I _D = 38.8 A | | 0.005 | | Ω |
| Drain-Source On-State Resistance ^a | R _{DS(on)} | $V_{GS} = 4.5 \text{ V}, I_D = 37 \text{ A}$ | | 0.006 | | |
| Forward Transconductance ^a | 9 _{fs} | V _{DS} = 15 V, I _D = 38.8 A | | 160 | | S |
| Dynamic ^b | | | | | | |
| Input Capacitance | C _{iss} | | | 2201 | | pF |
| Output Capacitance | C _{oss} | $V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ | | 525 | | |
| Reverse Transfer Capacitance | C _{rss} | | | 270 | | |
| Total Cata Charma | | $V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 38.8 \text{ A}$ | | 61 | 107 | |
| Fotal Gate Charge Q _g | | | 31.5 | 50 | | |
| Gate-Source Charge | Q _{gs} | $V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 28.8 \text{ A}$ | | 10 | | nC |
| Gate-Drain Charge | Q _{gd} | | | 6 | | |
| Gate Resistance | R _g | f = 1 MHz | | 1.4 | 2.1 | Ω |
| Turn-On Delay Time | t _{d(on)} | | | 18 | 27 | |
| Rise Time | t _r | V_{DD} = 15 V, R_L = 0.625 Ω | | 11 | 17 | ns |
| Turn-Off Delay Time | t _{d(off)} | $I_D\cong 24$ A, V_{GEN} = 10 V, R_g = 1 Ω | | 70 | 105 | |
| Fall Time | t _f | | | 10 | 15 | |
| Turn-On Delay Time | t _{d(on)} | | | 55 | 83 | |
| Rise Time | t _r | V_{DD} = 15 V, R_L = 0.67 Ω | | 180 | 270 | |
| Turn-Off Delay Time | t _{d(off)} | $I_D\cong 22.5$ A, V_{GEN} = 4.5 V, R_g = 1 Ω | | 55 | 83 | |
| Fall Time | t _f | | | 12 | 18 | |
| Drain-Source Body Diode Characteristic | es | | | | | |
| Continuous Source-Drain Diode Current | I _S | T _C = 25 °C | | | 120 | Λ |
| Pulse Diode Forward Current ^a | I _{SM} | | | | 120 | Α |
| Body Diode Voltage | V_{SD} | I _S = 22 A | | 0.8 | 1.2 | V |
| Body Diode Reverse Recovery Time | t _{rr} | | | 52 | 78 | ns |
| Body Diode Reverse Recovery Charge | Q _{rr} | 1 00 A di/d+ 100 A/:- T 05 00 | | 70.2 | 105 | nC |
| Reverse Recovery Fall Time | t _a | $I_F = 20 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$ | | 27 | | |
| Reverse Recovery Rise Time | t _b | | | 25 | | ns |

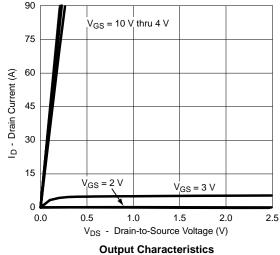
Notes:

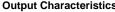
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

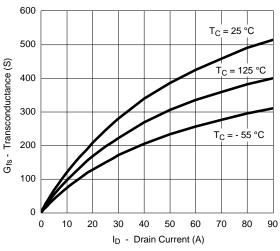
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



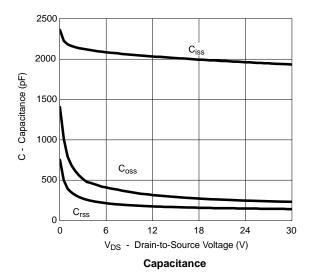
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





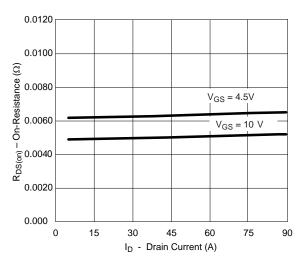


Transconductance

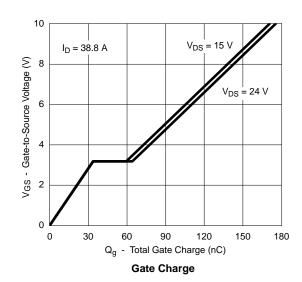


3.0 2.4 I_D - Drain Current (A) 1.8 1.2 T_C = 25 °C 0.6 T_C = 125 °C Γ_C = - 55 °C 0.0 V_{GS} - Gate-to-Source Voltage (V)

Transfer Characteristics

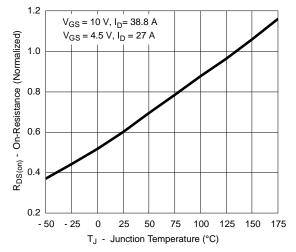


R_{DS(on)} vs. Drain Current





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



On-Resistance vs. Junction Temperature



 $\rm R_{\rm DS(on)}$ vs. $\rm V_{\rm GS}$ vs. Temperature



Forward Diode Voltage vs. Temperature



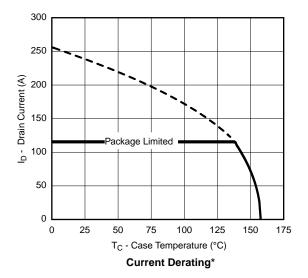
Threshold Voltage



Safe Operating Area, Junction-to-Ambient



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





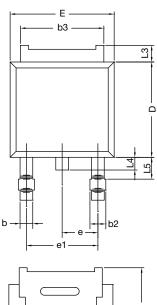
*The power dissipation P_D is based on $T_{J(max)}$ = 175 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

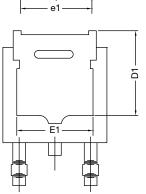


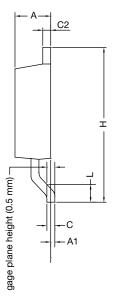
Normalized Thermal Transient Impedance, Junction-to-Case



TO-252AA CASE OUTLINE







| | MILLIMETERS | | ETERS INCHES | | | |
|---------------------------------|-------------|-------------|--------------|-------|--|--|
| DIM. | MIN. | MAX. | MIN. | MAX. | | |
| Α | 2.18 | 2.38 | 0.086 | 0.094 | | |
| A1 | - | 0.127 | - | 0.005 | | |
| b | 0.64 | 0.88 | 0.025 | 0.035 | | |
| b2 | 0.76 | 1.14 | 0.030 | 0.045 | | |
| b3 | 4.95 | 5.46 | 0.195 | 0.215 | | |
| С | 0.46 | 0.61 | 0.018 | 0.024 | | |
| C2 | 0.46 | 0.89 | 0.018 | 0.035 | | |
| D | 5.97 | 6.22 | 0.235 | 0.245 | | |
| D1 | 5.21 | - | 0.205 | - | | |
| Е | 6.35 | 6.73 | 0.250 | 0.265 | | |
| E1 | 4.32 | = | 0.170 | - | | |
| Н | 9.40 | 10.41 | 0.370 | 0.410 | | |
| е | 2.28 | BSC 0.090 E | | BSC | | |
| e1 | 4.56 BSC | | 0.180 BSC | | | |
| L | 1.40 | 1.78 | 0.055 | 0.070 | | |
| L3 | 0.89 | 1.27 | 0.035 | 0.050 | | |
| L4 | - | 1.02 | - | 0.040 | | |
| L5 | 1.14 | 1.52 | 0.045 | 0.060 | | |
| ECN: X12-0247-Rev. M, 24-Dec-12 | | | | | | |

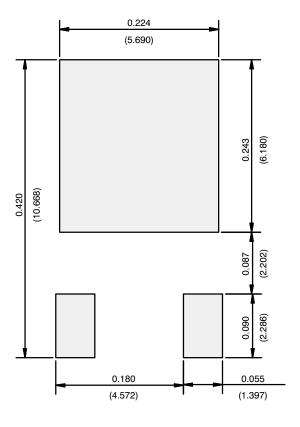
DWG: 5347

Note

• Dimension L3 is for reference only.



RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)



Recommended Minimum Pads Dimensions in Inches/(mm)

服务热线:400-655-8788 7



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